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				FILING DATE 04/26/01			group 2621		
U. S. PATENT DOCUMENT									
EXAMINER INITIALS		PATENT NO.	ISSUE DATE	PATENTEE		CLASS	SUBCLASS	FILING DATE	
Sce	AA	US 5 608 547 A	3/4/97	Nakatani Munehiro	et al	358	505		
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		DOCUMENT NO.	PUBLICATION DATE	COUNTRY OR PATENT OFFICE		CLASS	SUBCLASS	TRANSLATION	
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sce		PCT International Search Report (Application No. PCT/US 01/13477)							
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if									

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